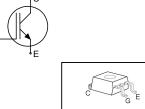


Fast IGBT in NPT-technology

- 75% lower *E*_{off} compared to previous generation combined with low conduction losses
- Short circuit withstand time 10 μ s
- Designed for:
 - Motor controls
 - Inverter
- NPT-Technology for 600V applications offers:
 - very tight parameter distribution
 - high ruggedness, temperature stable behaviour
 - parallel switching capability
- Qualified according to JEDEC² for target applications
- Pb-free lead plating; RoHS compliant
- Complete product spectrum and PSpice Models : <u>http://www.infineon.com/igbt/</u>



PG-TO-263-3-2 (D²-PAK) (TO-263AB)

Туре	V _{CE}	I _c	V _{CE(sat)150°C}	Tj	Marking	Package
SGB06N60	600V	6A	2.3V	150°C	G06N60	PG-TO-263-3-2

Maximum Ratings

Parameter	Symbol	Value	Unit	
Collector-emitter voltage	V _{CE}	600	V	
DC collector current	I _C		А	
$T_{\rm C}$ = 25°C		12		
$T_{\rm C}$ = 100°C		6.9		
Pulsed collector current, t_p limited by T_{jmax}	I _{Cpuls}	24		
Turn off safe operating area	-	24		
$V_{CE} \le 600 \text{V}, \ T_j \le 150^{\circ} \text{C}$				
Gate-emitter voltage	V _{GE}	±20	V	
Avalanche energy, single pulse	E _{AS}	34	mJ	
$I_{\rm C}$ = 6 A, $V_{\rm CC}$ = 50 V, $R_{\rm GE}$ = 25 Ω ,				
start at $T_j = 25^{\circ}C$				
Short circuit withstand time ¹⁾	t _{sc}	10	μs	
V_{GE} = 15V, $V_{\text{CC}} \le 600$ V, $T_j \le 150^{\circ}$ C				
Power dissipation	P _{tot}	68	W	
$T_{\rm C}$ = 25°C				
Operating junction and storage temperature	T _j , T _{stg}	-55+150	°C	
Soldering temperature (reflow soldering, MSL1)		245		

² J-STD-020 and JESD-022

¹⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.



Thermal Resistance

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic	· ·			
IGBT thermal resistance,	R _{thJC}		1.85	K/W
junction – case				
Thermal resistance,	R _{thJA}		40	
junction – ambient ¹⁾				

Electrical Characteristic, at T_j = 25 °C, unless otherwise specified

Deremeter	Symbol	Conditions	Value			Unit
Parameter	Symbol	Conditions	min.	Тур.	max.	
Static Characteristic	•	•				
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{\rm GE}$ =0V, $I_{\rm C}$ =500 μ A	600	-	-	V
Collector-emitter saturation voltage	V _{CE(sat)}	$V_{\rm GE}$ = 15V, $I_{\rm C}$ =6A				
		T _j =25°C	1.7	2.0	2.4	
		<i>T</i> _j =150°C	-	2.3	2.8	
Gate-emitter threshold voltage	V _{GE(th)}	$I_{\rm C} = 250 \mu {\rm A}, V_{\rm CE} = V_{\rm GE}$	3	4	5	
Zero gate voltage collector current	I _{CES}	$V_{\rm CE}$ =600V, $V_{\rm GE}$ =0V				μA
		<i>T</i> _j =25°C	-	-	20	
		<i>T</i> _j =150°C	-	-	700	
Gate-emitter leakage current	I _{GES}	$V_{CE}=0V, V_{GE}=20V$	-	-	100	nA
Transconductance	g _{fs}	V _{CE} =20V, <i>I</i> _C =6A	-	4.2	-	S
Dynamic Characteristic						
Input capacitance	Ciss	V _{CE} =25V,	-	350	420	pF
Output capacitance	Coss	V _{GE} =0V,	-	38	46	
Reverse transfer capacitance	Crss	f=1MHz	-	23	28	
Gate charge	Q _{Gate}	V _{CC} =480V, <i>I</i> _C =6A	-	32	42	nC
		V _{GE} =15V				
Internal emitter inductance	LE		-	7	-	nH
measured 5mm (0.197 in.) from case						
Short circuit collector current ²⁾	I _{C(SC)}	V_{GE} =15V, t_{SC} ≤10µs V_{CC} ≤600V, T_{j} ≤150°C	-	60	-	A

 ¹⁾ Device on 50mm*50mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70μm thick) copper area for collector connection. PCB is vertical without blown air.
 ²⁾ Allowed number of short circuits: <1000; time between short circuits: >1s.



Switching Characteristic, Inductive Load, at Ti=25 °C

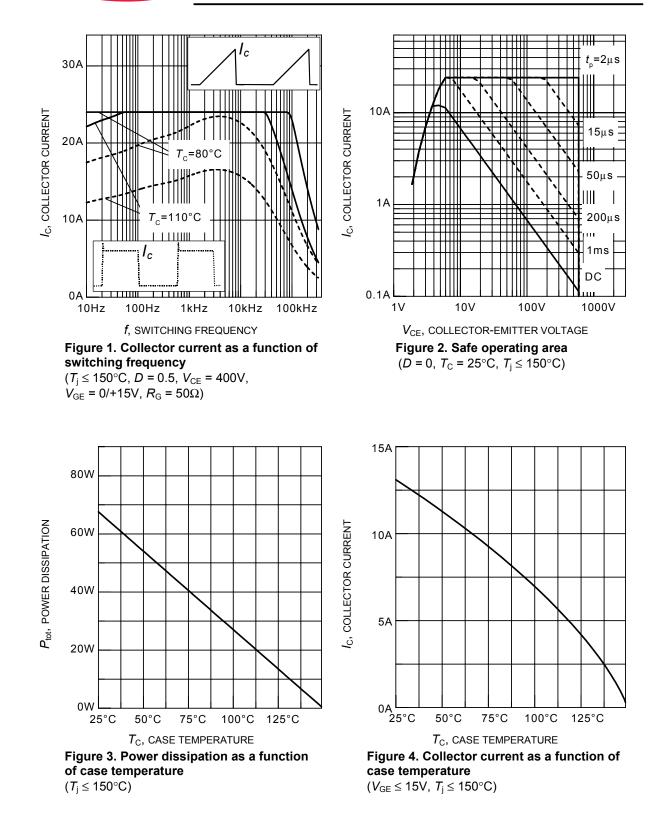
Parameter	Symbol	Conditions	Value			11
			min.	typ.	max.	Unit
IGBT Characteristic						
Turn-on delay time	t _{d(on)}	$T_{j}=25 °C,$ $V_{CC}=400 V, I_{C}=6A,$ $V_{GE}=0/15 V,$ $R_{G}=50\Omega,$ $L_{\sigma}^{(1)}=180 nH,$ $C_{\sigma}^{(1)}=250 pF$ Energy losses include "tail" and diode	-	25	30	ns
Rise time	t _r		-	18	22	
Turn-off delay time	$t_{d(off)}$		-	220	264	
Fall time	t _f		-	54	65	
Turn-on energy	Eon		-	0.110	0.127	mJ
Turn-off energy	E _{off}		-	0.105	0.137	
Total switching energy	E _{ts}	reverse recovery.	-	0.215	0.263	

Switching Characteristic, Inductive Load, at T_i=150 °C

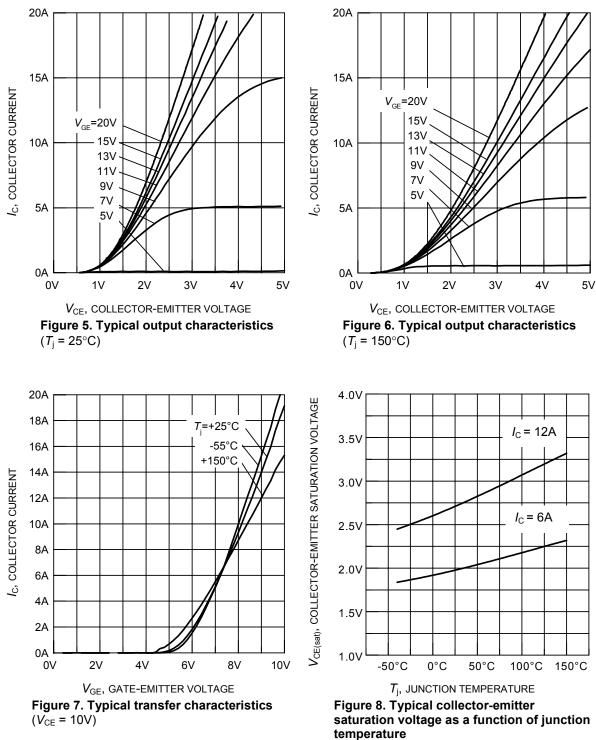
Parameter	Symbol	Conditions	Value			Unit
			min.	typ.	max.	Unit
IGBT Characteristic						
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =150°C	-	24	29	ns
Rise time	tr	V_{CC} =400V, I_C =6A, V_{GE} =0/15V, R_G =50 Ω , $L_{\sigma}^{(1)}$ =180nH, $C_{\sigma}^{(1)}$ =250pF Energy losses include "tail" and diode reverse recovery.	-	17	20	
Turn-off delay time	$t_{d(off)}$		-	248	298	
Fall time	t _f		-	70	84	
Turn-on energy	Eon		-	0.167	0.192	mJ
Turn-off energy	$E_{\rm off}$		-	0.153	0.199	
Total switching energy	E _{ts}		-	0.320	0.391]

 $^{1)}$ Leakage inductance L $_{\sigma}$ and Stray capacity C $_{\sigma}$ due to dynamic test circuit in Figure E.





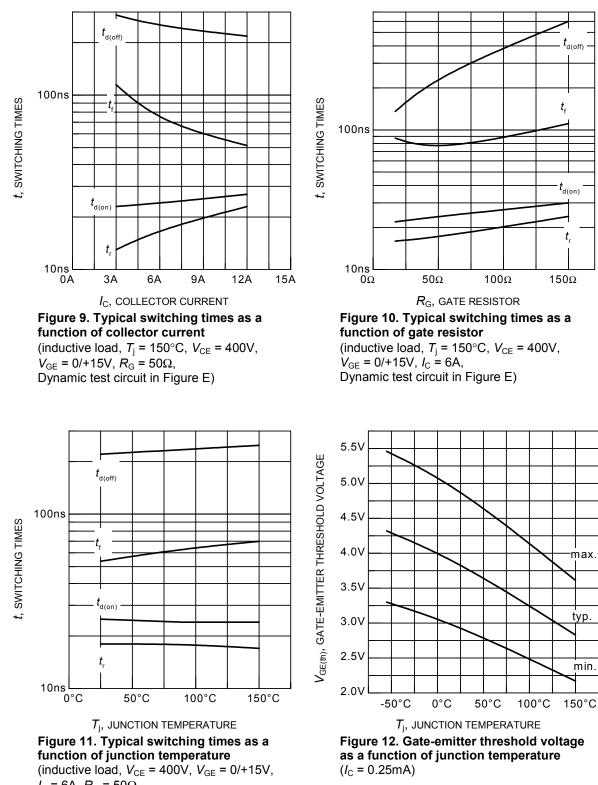




 $(V_{\rm GE} = 15V)$











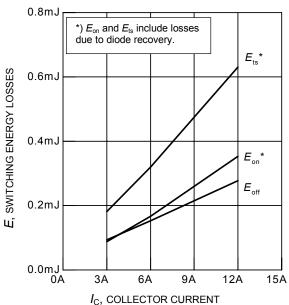


Figure 13. Typical switching energy losses as a function of collector current (inductive load, $T_j = 150^{\circ}$ C, $V_{CE} = 400$ V, $V_{GE} = 0/+15$ V, $R_G = 50\Omega$, Dynamic test circuit in Figure E)

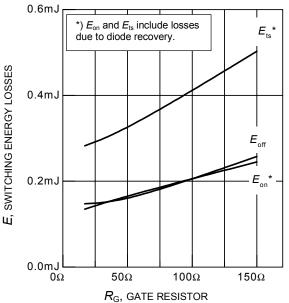
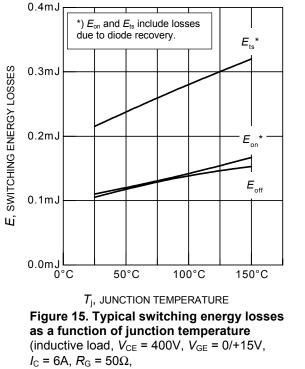
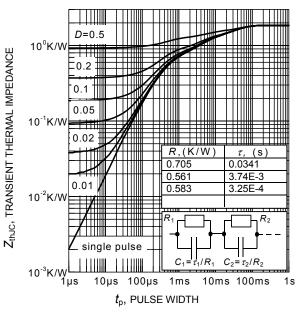
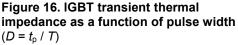


Figure 14. Typical switching energy losses as a function of gate resistor (inductive load, $T_j = 150^{\circ}$ C, $V_{CE} = 400$ V, $V_{GE} = 0/+15$ V, $I_C = 6$ A, Dynamic test circuit in Figure E)



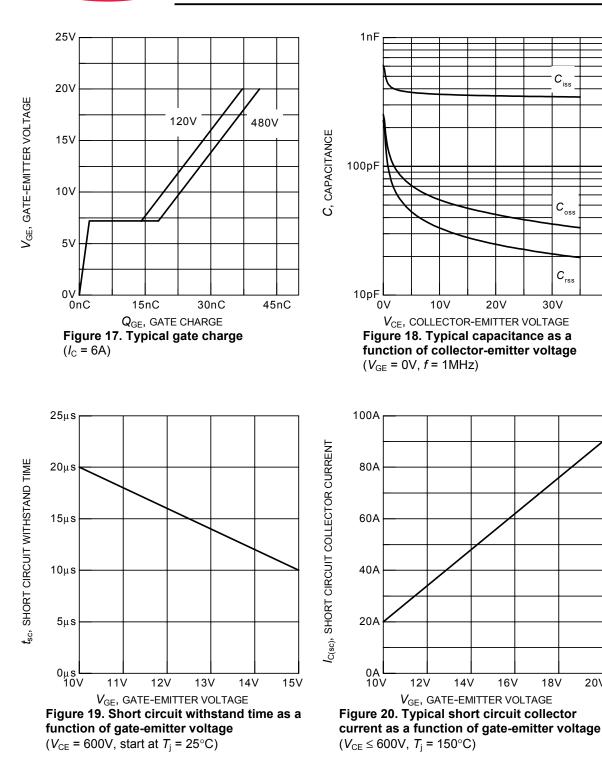
Dynamic test circuit in Figure E)





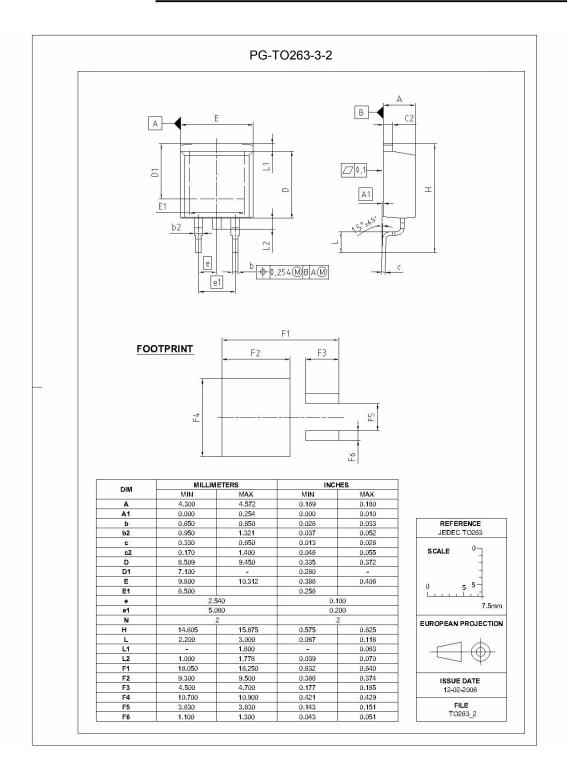






20V







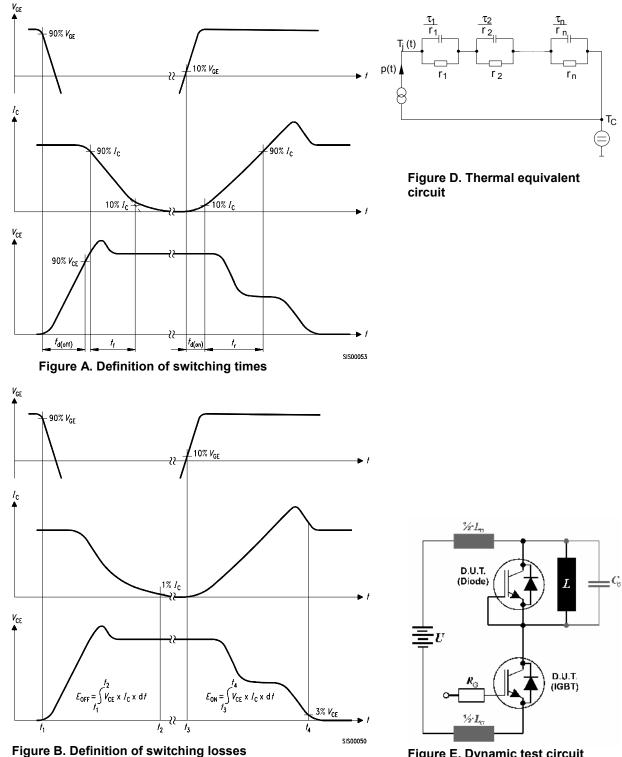


Figure E. Dynamic test circuit Leakage inductance L_{σ} =180nH and Stray capacity C_{σ} =250pF.



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